Form 1449 (Modified)	Docket No.	Application No.:
	READP037	09/476,189
Information Disclosure	Applicant:	
Statement By Applicant	Read-Rite Corporation	
IPE	Filing Date	Group
(Use Several Sheets if Necessary)	January 3, 2000	2754

OCT 1 8 2000

## **U.S. Patent Documents**

Examiner						Sub-	Filing
Initial	No.	Patent No.	Date	Patentee	Class	class	Date
MB	Α	4,670,806	6/2/87	Ghose			
MB	В	4,081,846	3/28/78	Roscamp et al.			
MB	С	4,802,042	1/31/89	Strom		ECH	
MB	D	5,327,311	7/5/94	Ananth et al.			
MB	E	5,274,518	12/28/93	Chapin et al.		(E)	125 EEI
MB	F	5,781,376	7/14/98	Tsukamoto		ITER	5
MB	G	4,636,894	1/13/87	Mo			/E 20
MB	Н	5,768,055	6/16/98	Tian et al.		27	
MB	I	5,343,343	8/30/94	Chapin et al.		00	
MB	J	4,218,715	8/19/80	Garnier			
MB	K	5,198,934	3/30/93	Kubo et al.			

Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	slation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
	L							
	M						_	
	N							
	0							
	P							

## **Other Documents**

Examiner		
Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
	S	
	T	
Examiner /	101	Q_1 Date Considered
1/1/2	101	9/25/03

Examiner Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form 1449 (Modified)	Docket No.	Application No.:
	READP037	09/476,189
Information Disclosure	Applicant:	
Statement By Applicant	Read-Rite Corporation	
OIPE	Filing Date	Group
(Use Several Sheets if Necessary)	January 3, 2000	2754

OCT 1 8 2000

U.S. Patent Documents

\2		<i>*</i>	U.S. I att	nt Documents			
Exampler Initial TRA	. 64	<b>S</b>				Sub-	Filing
Initial TRA	DENO	Patent No.	Date	Patentee	Class	class	Date
MB	Α	5,572,386	11/5/96	Ananth et al.			
MB	В	5,726,831	3/10/98	White		ECH.	
My	C	5,610,784	3/11/97	Dorius et al.			
MB	D	5,739,981	4/14/98	Cha et al.		CENTER	<u>7</u>
MB	E	5,705,287	1/6/98	Doerner et al.		31	5
	F					70 20	祖
	G					~ <b>,</b> '	
	Н					8	
	I				-3-		
	J						
·	K						

Foreign Patent or Published Foreign Patent Application

Examiner		Document	Publication	Country or		Sub-	Trans	slation
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No
	L							
	M	-)(-						
	N							
	0							
	P							

## Other Documents

		Other Documents
Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
	S	
	T	V V V V V V V V V V V V V V V V V V V
Examiner	9	Date Considered

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.